

RU20P18L-VB Datasheet P-Channel 20-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^d	Q _g (Typ.)			
- 20	0.016 at V_{GS} = - 4.5 V	- 40	13 nC			
	0.025 at V _{GS} = - 2.5 V	- 35	13 110			



- Halogen-free According to IEC 61249-2-21
 Definition
- Trench Power MOSFET
- 100 % R_g Tested

APPLICATIONS

- · Load Switch
- Battery Switch
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 \textbf{F-Channel MOSFET}
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ABSOLUTE MAXIMUM RATINGS T	A = 25 °C, unless othe	erwise noted			
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage	V _{DS}	- 20	V		
Gate-Source Voltage		V _{GS}	± 12	v	
	T _C = 25 °C		- 40		
Continuous Drain Current (T ₁ = 150 °C)	T _C = 70 °C		- 35		
Continuous Drain Current $(1) = 150^{\circ}$ C)	T _A = 25 °C	I _D	- 30.0 ^{a, b}		
	T _A = 70 °C		- 28 ^{a, b}	А	
Pulsed Drain Current	I _{DM}	- 150			
Continuous Source-Drain Diode Current	T _C = 25 °C	L.	- 3.5		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	- 2.1 ^{a, b}		
	T _C = 25 °C		40		
Mauiaum Daura Dissis atian	T _C = 70 °C		27	w	
Maximum Power Dissipation	T _A = 25 °C	P _D	2.5 ^{a, b}	vv	
	T _A = 70 °C	1	1.6 ^{a, b}		
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient ^{a, c}	t ≤ 10 s	R _{thJA}	40	50	°C/W
Maximum Junction-to-Foot	Steady State	R _{thJF}	24	30	0/00

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. t = 10 s.

c. Maximum under Steady State conditions is 95 °C/W.

d. Based on $T_C = 25 \text{ °C}$.

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SPECIFICATIONS T _J = 25 °C, unless otherwise noted							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static			-				
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	l _D = - 250 μA		- 31		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			4.5		11107 C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = -250 \ \mu A$	-0.5		- 2.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 12 V$			± 100	nA	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 20 V, V _{GS} = 0 V V _{DS} = -20 V, V _{GS} = 0 V, T _J = 55 °C			- 1 - 5	μA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 V, V_{GS} = -10 V$	- 40		0	A	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = -4.5 \text{ V} \text{ I}_{\text{D}} = -7.0 \text{ A}$ $V_{GS} = -2.5 \text{ V}, \text{ I}_{\text{D}} = -5.6 \text{ A}$		0.016		Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 7.0 A		18		S	
Dynamic ^b	-			11			
Input Capacitance	C _{iss}			1455			
Output Capacitance	C _{oss}	V _{DS} = - 10 V, V _{GS} = 0 V, f = 1 MHz		180		pF	
Reverse Transfer Capacitance	C _{rss}			145			
Total Gate Charge	Q _q	V _{DS} = - 10 V, V _{GS} = - 10 V, I _D = - 7.0 A		25	38		
-	8	5		13	20	nC	
Gate-Source Charge	Q _{gs}	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -7.0 \text{ A}$		3.5			
Gate-Drain Charge	Q _{gd}			5.5			
Gate Resistance	R _g	f = 1 MHz	0.4	2.0	4.0	Ω	
Turn-On Delay Time	t _{d(on)}			10	20		
Rise Time	t _r	V_{DD} = - 10 V, R _L = 2.7 Ω		13	20	_	
Turn-Off DelayTime	t _{d(off)}	$I_{D}\cong$ - 5.6 A, V_{GEN} = - 10 V, R_{g} = 1 Ω		23	35		
Fall Time	t _f			9	18	ns	
Turn-On Delay Time	t _{d(on)}			38	57	110	
Rise Time	t _r	V_{DD} = - 10 V, R_L = 2.7 Ω		89	134	_	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong$ - 5.6 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		22	33		
Fall Time	t _f			11	17		
Drain-Source Body Diode Characteris	stics						
Continous Source-Drain Diode Current	۱ _S	T _C = 25 °C			- 6.5	A	
Pulse Diode Forward Current	I _{SM}				- 30	~	
Body Diode Voltage	V _{SD}	$I_{S} = -5.6 \text{ A}, V_{GS} = 0 \text{ V}$		- 0.71	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			22	33	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 5.6 A, dl/dt = 100 A/μs, T _J = 25 °C		17	26	nC	
Reverse Recovery Fall Time	t _a			13			
Reverse Recovery Rise Time	t _b			9		ns	

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



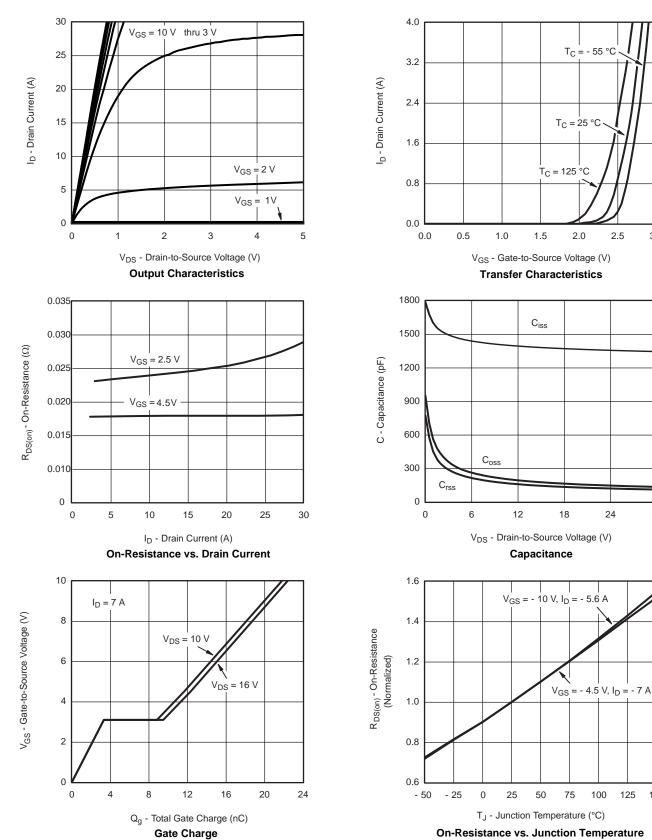
2.5

24

5.6 A

30

3.0



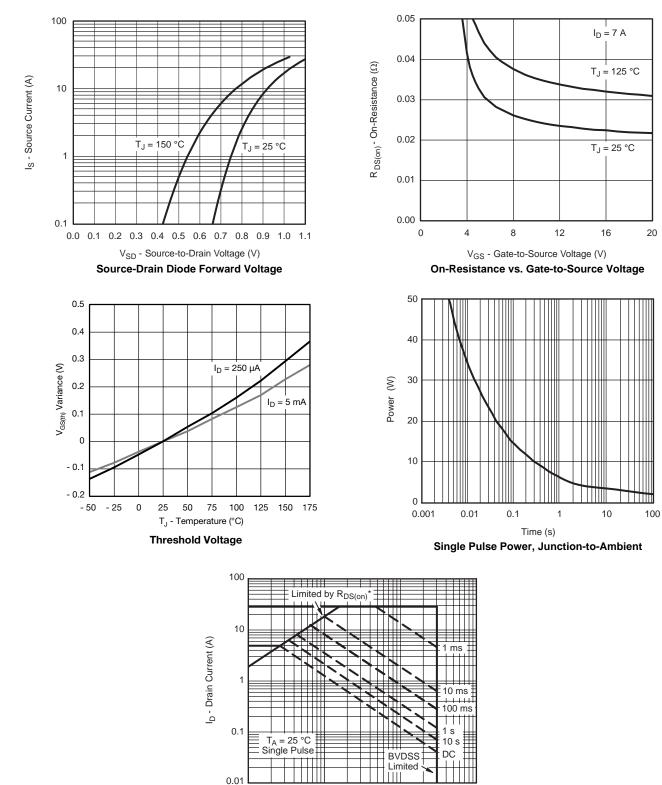
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

125

100

150





10

 $\label{eq:VDS} V_{DS} \mbox{ - Drain-to-Source Voltage (V)} $$ V_{GS} \mbox{ > minimum V}_{GS} at which $R_{DS(on)}$ is specified $$ Safe Operating Area $$$

1

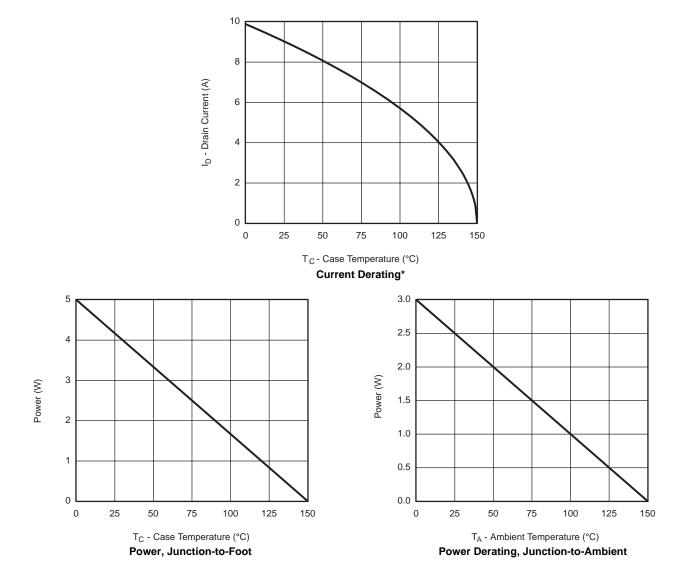
100

0.1

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



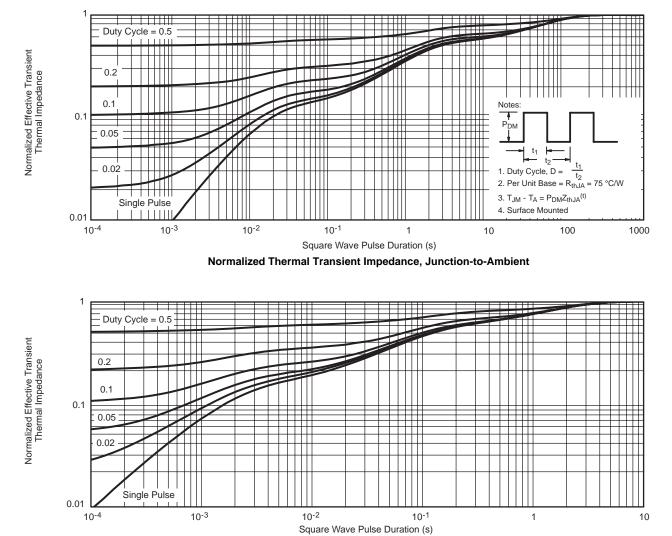
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



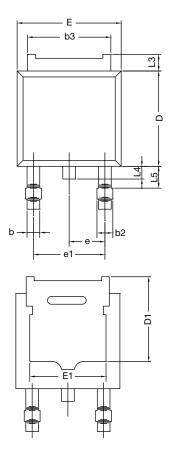
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

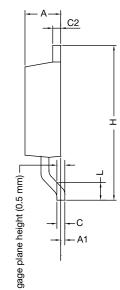


Normalized Thermal Transient Impedance, Junction-to-Foot



TO-252AA CASE OUTLINE





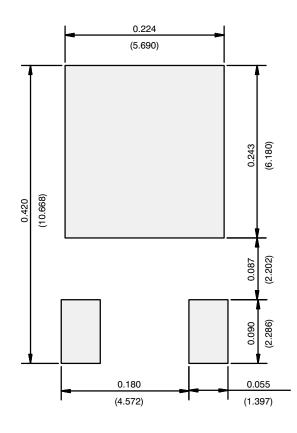
	MILLIN	IETERS	INC	INCHES	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	5.21	-	0.205	-	
E	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28	2.28 BSC 0.090 BSC			
e1	4.56 BSC		0.180 BSC		
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.14	1.52	0.045	0.060	
ECN: X12-0247-Rev. M, 24-Dec-12 DWG: 5347					

Note

• Dimension L3 is for reference only.



RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)



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